Searcn Notes			

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/624,867	KOBAYASHI ET AL.	
Examiner	Art Unit	
Mark W. Bockelman	3766	

SEARCHED			
Class	Subclass	Date	Examiner
607	68.74	9-4-06	MB
upto	læ	12-A-06	MB
•••		·	
			<del></del>
<u></u>			
		,	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
60	abre	12-19-06	MB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
act	DATE	EXMR
8 607/ \$cc/s. +	9-3-06	MB
rectangles and pulse		
up to dete	12-19-06	MB
607 / d. ccls. +	ke.	
pulses same (density		
or densities		
		·
•		
	-	{